

Application/Control No.	Applicant(s)/Patent under Reexamination
09/311,313	MCBRIDE, JOHN G
Examiner	Art Unit
Leigh Marie Garbowski	2825

	SEAR	CHED	· · ·
Class	Subclass	Date	Examiner
716	1-2,4-6,17- 18	3/18/2005	LMG
703	13-14	3/18/2005	LMG
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INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
WEST and IEEExplore identif\$ determin\$ analy\$ feedback transistor fet field effect transistor drc rule verif\$ loop pfet nfet	3/18/2005	LMG
consulted Matthew Smith [SPE 2825] regarding 112 rejections	3/17/2005	LMG